



# Mini Workshop on "Characterization of High Brightness Beams"

## Monday 26 May 2008

### FLASH talks on data taking and data analysis - S3 (16:15 - 17:50)

time	[id] title	presenter
16:15	[13] Emittance measurement and analysis tools for FLASH	GERTH, C.
17:00	[14] Analysis of LCLS emittance measurement data with FLASH tools	
17:25	[15] Optics solutions for the XFEL injector diagnostics	KOT, Y.